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Substitute for Form 1449 V & B/F 10		Application Number	10/591,581		
NFORMATION DISC	TOSUBE	Confirmation Number	3372		
361		Filing Date	September 5, 2006		
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			U.S. 1	PATENT DOCUME	ENTS
Examiner Initials*	Cite	Document Number		Publication Date	
	No. ^t	Number Kind Code MM-DD-YYYY		Name of Patentee or Applicant of Cited Documer	
-		US			
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Examiner Initials*	Cite No. ¹	Foreign Patent Document			Publication Date	Name of Patentee or	
		Country Code ³	Number ⁴	Kind Code ⁵ (if known)	MM-DD-YYYY	Applicant of Cited Document	Translation ⁶
		JР	2-288388		11-28-1990	TOSHIBA CORP	Abstract
		JР	5-283744		10-29-1993	TOSHIBA CORP	Abstract and machine translation
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		Sir Peter HIRSH, et al.; "Electron Microscopy of Thin Crystals"; Krieger Publishing Company, First Edition 1965; Reprinted and Revised 1967; Second Revised Edition 1977 (pp. 306-307)				
		00/00/2010				
Framiner S		/Hrayr A. Sayadian/ Pata Considered 06/06/2010				

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